Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/622,643	EBERLE ET AL.
Examiner	Art Unit

3679

David E. Bochna

SEARCHED					
Class	Subclass	Date	Examiner		
	-				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
285	124.2,321	12/20/2005	DB		
	124.4				
	124.5				
285/140.1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated the previous search	12/20/2005	DB		